

### 1. General description

Silicon Carbide MOSFET in a 3-lead TO247 plastic package, designed for high frequency, high efficiency systems.



### 2. Features and benefits

- Optimized for fly-back topologies
- 15V/0V gate-source voltage compatible with fly-back controllers
- 100% UIS Tested
- Controllable dV/dt for optimized EMI
- Reduced cooling requirements
- RoHS compliant

### 3. Applications

- Switch Mode Power Supplies
- Auxiliary Power Supplies
- Solar Inverter

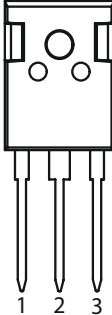
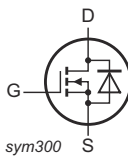
### 4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
<b>Absolute maximum rating</b>							
$V_{DS}$	drain-source voltage	$25\text{ °C} \leq T_j \leq 175\text{ °C}$		-	-	1700	V
$I_D$	drain current	$V_{GS} = 18\text{ V}; T_{mb} = 25\text{ °C}$		-	-	7	A
$P_{tot}$	total power dissipation	$T_{mb} = 25\text{ °C}$		-	-	79	W
$T_j$	junction temperature			-55	-	175	°C
<b>Static characteristics</b>							
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 15\text{ V}; I_D = 1\text{ A}; T_j = 25\text{ °C}$		-	1000	-	mΩ
		$V_{GS} = 18\text{ V}; I_D = 1\text{ A}; T_j = 25\text{ °C}$		-	750	1000	mΩ
<b>Dynamic characteristics</b>							
$Q_{G(tot)}$	total gate charge	$I_D = 2\text{ A}; V_{DS} = 1200\text{ V}; V_{GS} = 0V/18\text{ V}; T_j = 25\text{ °C}$		-	12	-	nC
$Q_{GD}$	gate-drain charge			-	5	-	nC
<b>Source-drain diode</b>							
$Q_r$	recovered charge	$I_{SD} = 1\text{ A}; di/dt = 500\text{ A}/\mu\text{s}; V_{DS} = 400\text{ V}; T_j = 25\text{ °C}$		-	38	-	nC

## 5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	D	drain		
3	S	source		
mb	D	mounting base; connected to drain		

## 6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WNSC2M1K0170W	TO247	WNSC2M1K0170WQ	Tube	30	TO247N	20-July-2016

## 7. Marking

Table 4. Marking codes

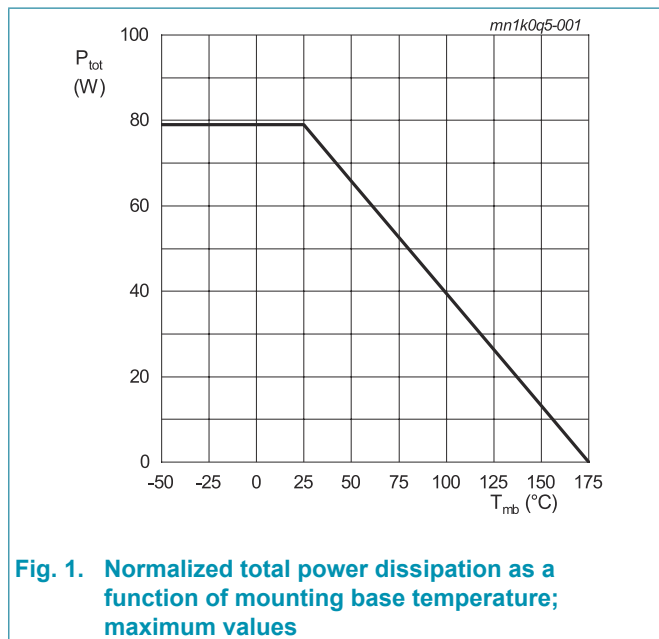
Type number	Marking codes
WNSC2M1K0170W	WNSC2M 1K0170W

## 8. Limiting values

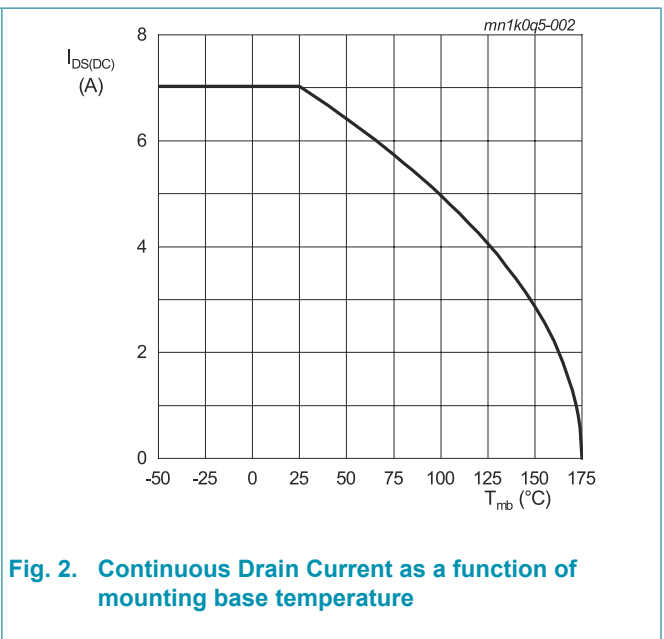
**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Min	Max	Unit
$V_{DS}$	drain-source voltage	$25\text{ °C} \leq T_j \leq 175\text{ °C}$		-	1700	V
$V_{GS,max}$	gate-source voltage			-10	22	V
$V_{GS,op}$	gate-source voltage			-5	18	V
$P_{tot}$	total power dissipation	$T_{mb} = 25\text{ °C}$		-	79	W
$I_D$	drain current	$V_{GS} = 18\text{ V}; T_{mb} = 25\text{ °C}$		-	7	A
		$V_{GS} = 18\text{ V}; T_{mb} = 100\text{ °C}$		-	5	A
$I_{DM}$	peak drain current	pulsed; $t_p \leq 10\text{ }\mu\text{s}; T_{mb} = 25\text{ °C}$		-	20	A
$E_{as}$	single pulse drain-to-source avalanche	$I_{AS} = 7\text{ A}; L = 1\text{ mH}; V_{DD} = 100\text{ V}; T_{j(init)} = 25\text{ °C}$		24.5	-	mJ
$T_{stg}$	storage temperature			-55	175	°C
$T_j$	junction temperature			-55	175	°C
$T_{sld(M)}$	peak soldering temperature			-	260	°C



**Fig. 1. Normalized total power dissipation as a function of mounting base temperature; maximum values**



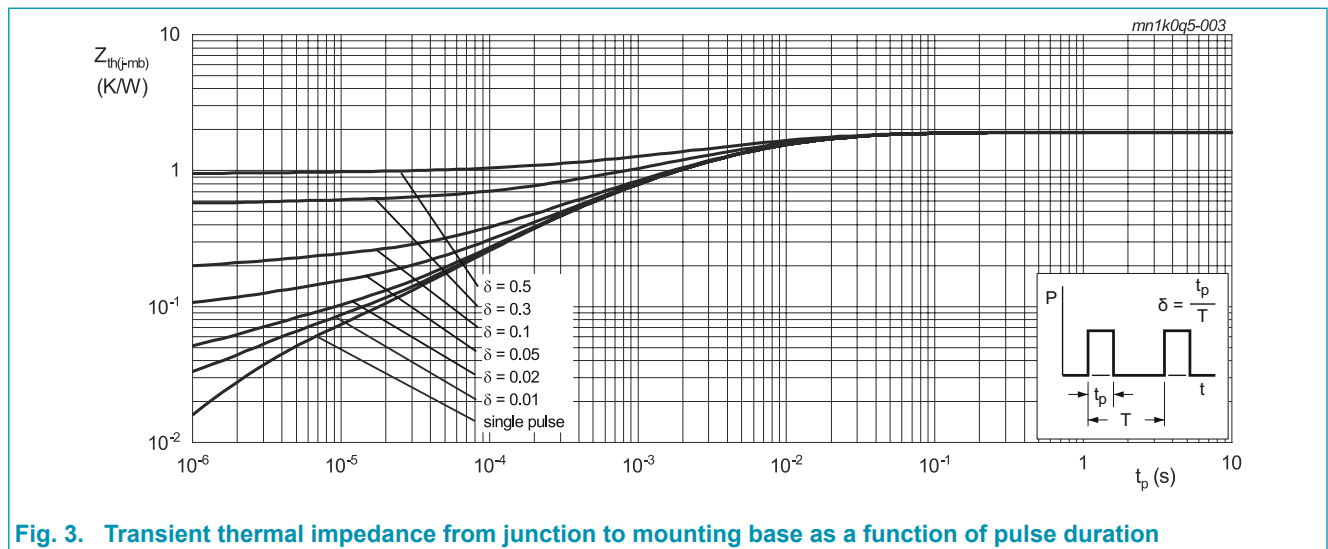
**Fig. 2. Continuous Drain Current as a function of mounting base temperature**

## 9. Thermal & Mechanical characteristics

**Table 6. Thermal & Mechanical characteristics**

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base			-	-	1.90	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air		-	40	-	K/W
$M_d$	Mounting torque	M3 or 6 - 32 screw		-	-	0.6	Nm

Note: It is recommended that a metal washer is inserted between screw head and mounting tab.  
Do not use self-tapping screws.  
Device is ESD sensitive. Handling precautions are recommended.

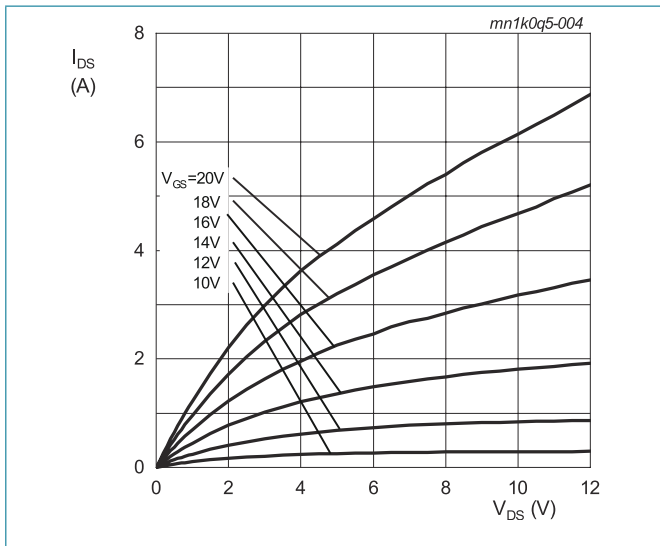


**Fig. 3. Transient thermal impedance from junction to mounting base as a function of pulse duration**

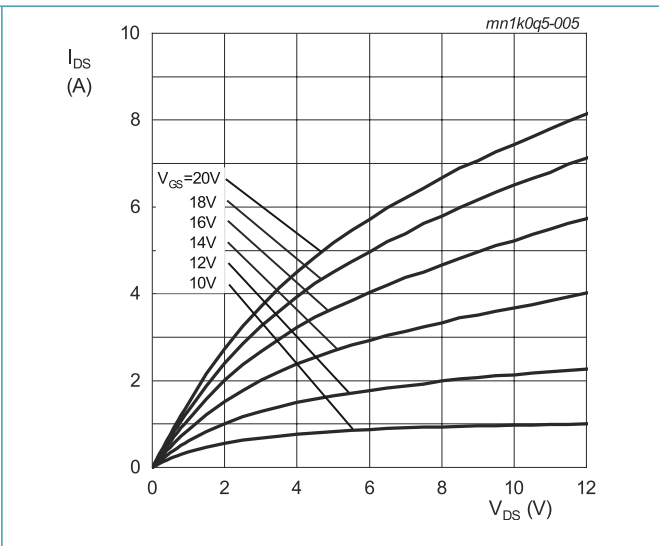
## 10. Characteristics

Table 7. Characteristics

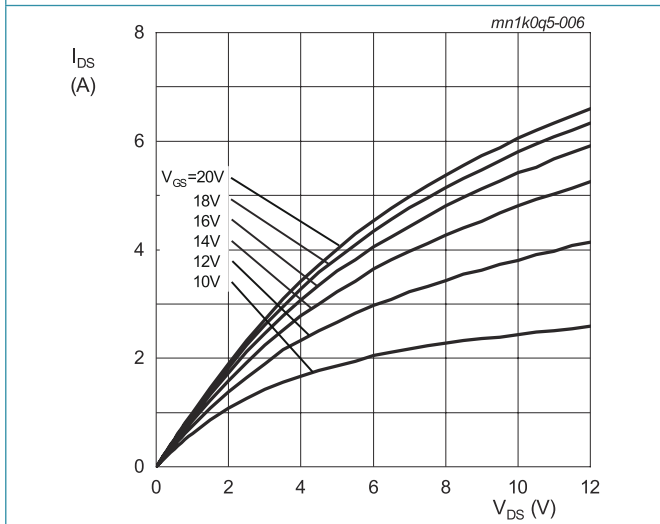
Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit	
<b>Static characteristics</b>								
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 100 \mu A$ ; $V_{GS} = 0 V$ ; $T_j = 25 \text{ }^\circ C$		1700	-	-	V	
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 0.8 \text{ mA}$ ; $V_{DS} = 10 V$ ; $T_j = 25 \text{ }^\circ C$		2.3	3.2	4.2	V	
		$I_D = 0.8 \text{ mA}$ ; $V_{DS} = 10 V$ ; $T_j = 150 \text{ }^\circ C$		-	2.4	-	V	
$I_{DSS}$	drain leakage current	$V_{DS} = 1700 V$ ; $V_{GS} = 0 V$ ; $T_j = 25 \text{ }^\circ C$		-	0.1	10	$\mu A$	
		$V_{DS} = 1700 V$ ; $V_{GS} = 0 V$ ; $T_j = 150 \text{ }^\circ C$		-	1	-	$\mu A$	
$I_{GSS}$	gate leakage current (absolute value)	$V_{GS} = 18 V$ ; $V_{DS} = 0 V$ ; $T_j = 25 \text{ }^\circ C$		-	10	100	nA	
		$V_{GS} = -10 V$ ; $V_{DS} = 0 V$ ; $T_j = 25 \text{ }^\circ C$		-	10	100	nA	
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 15 V$ ; $I_D = 1 A$ ; $T_j = 25 \text{ }^\circ C$		-	1000	-	m $\Omega$	
		$V_{GS} = 18 V$ ; $I_D = 1 A$ ; $T_j = 25 \text{ }^\circ C$		-	750	1000	m $\Omega$	
		$V_{GS} = 18 V$ ; $I_D = 1 A$ ; $T_j = 150 \text{ }^\circ C$		-	1050	-	m $\Omega$	
$R_G$	gate resistance	$f = 1 \text{ MHz}$ ; $T_j = 25 \text{ }^\circ C$		-	16	-	$\Omega$	
$g_{fs}$	transconductance	$V_{DS} = 10 V$ ; $I_D = 1 A$ ; $T_j = 25 \text{ }^\circ C$		-	0.5	-	S	
<b>Dynamic characteristics</b>								
$Q_{G(tot)}$	total gate charge	$I_D = 2 A$ ; $V_{DS} = 1200 V$ ; $V_{GS} = 0 V/18 V$ ; $T_j = 25 \text{ }^\circ C$		-	12	-	nC	
$Q_{GS}$	gate-source charge			-	3.8	-	nC	
$Q_{GD}$	gate-drain charge			-	5	-	nC	
$C_{iss}$	input capacitance	$V_{DS} = 1000 V$ ; $V_{GS} = 0 V$ ; $f = 1 \text{ MHz}$ ; $T_j = 25 \text{ }^\circ C$		-	225	-	pF	
$C_{oss}$	output capacitance			-	15	-	pF	
$C_{rss}$	reverse transfer capacitance			-	2.8	-	pF	
$E_{oss}$	Coss stored energy			-	7.5	-	$\mu J$	
$t_{d(on)}$	turn-on delay time		$V_{DS} = 1000 V$ ; $V_{GS} = -3/18 V$ ; $R_{G(ext)} = 5.1 \Omega$ ; $I_D = 2 A$ ; $L = 4.8 \text{ mH}$ ; $T_j = 25 \text{ }^\circ C$		-	5.6	-	ns
$t_r$	rise time				-	18	-	ns
$t_{d(off)}$	turn-off delay time			-	7.8	-	ns	
$t_f$	fall time			-	60	-	ns	
$E_{on}$	turn-on energy (Body Diode FWD)			-	57	-	$\mu J$	
$E_{off}$	turn-off energy (Body Diode FWD)			-	11	-	$\mu J$	
<b>Source-drain diode</b>								
$V_{SD}$	source-drain voltage	$V_{GS} = 0 V$ ; $I_F = 1 A$ ; $T_j = 25 \text{ }^\circ C$		-	3.9	-	V	
		$V_{GS} = 0 V$ ; $I_F = 1 A$ ; $T_j = 150 \text{ }^\circ C$		-	3.4	-	V	
$t_{rr}$	reverse recovery time	$I_{SD} = 1 A$ ; $di/dt = 500 A/\mu s$ ; $V_{DS} = 400 V$ ; $T_j = 25 \text{ }^\circ C$		-	36	-	ns	
$Q_r$	recovered charge			-	38	-	nC	
$I_{rrm}$	reverse recovery current			-	1.8	-	A	



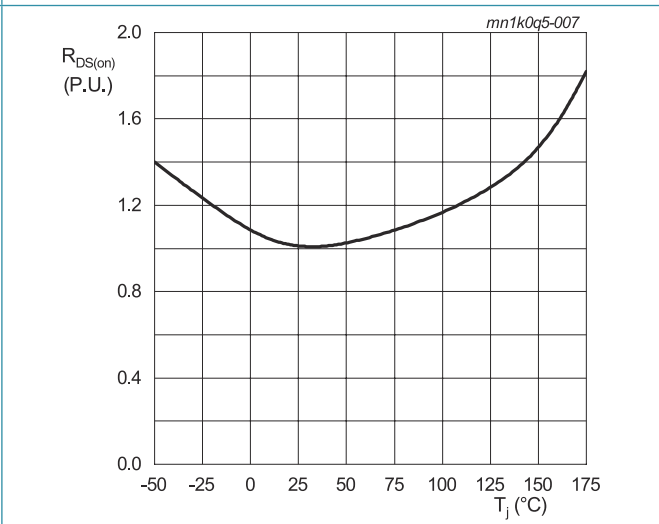
$T_j = -55\text{ }^\circ\text{C}; t_p < 200\text{ }\mu\text{s}$   
**Fig. 4. Output characteristics; drain current as a function of drain-source voltage; typical values**



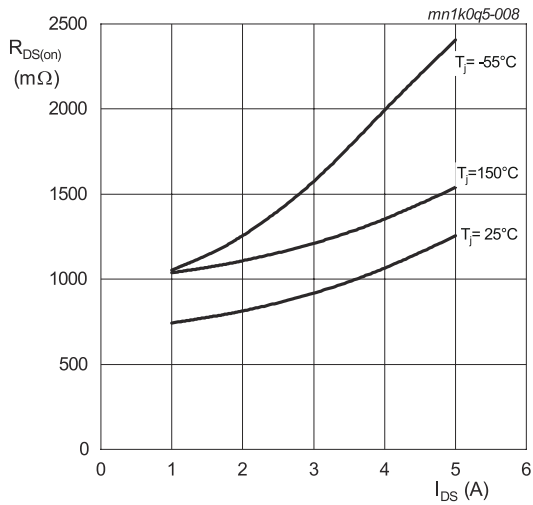
$T_j = 25\text{ }^\circ\text{C}; t_p < 200\text{ }\mu\text{s}$   
**Fig. 5. Output characteristics; drain current as a function of drain-source voltage; typical values**



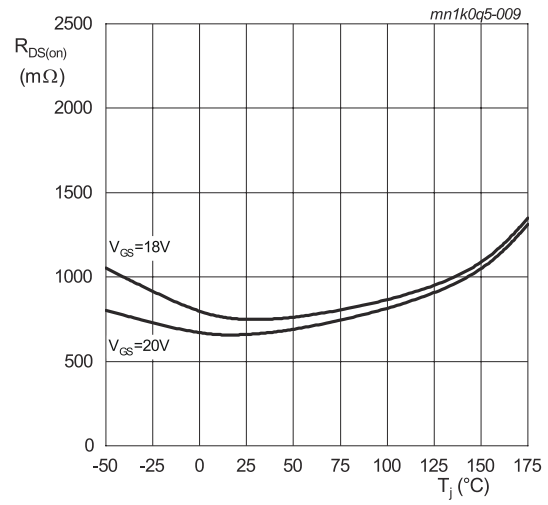
$T_j = 150\text{ }^\circ\text{C}; t_p < 200\text{ }\mu\text{s}$   
**Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values**



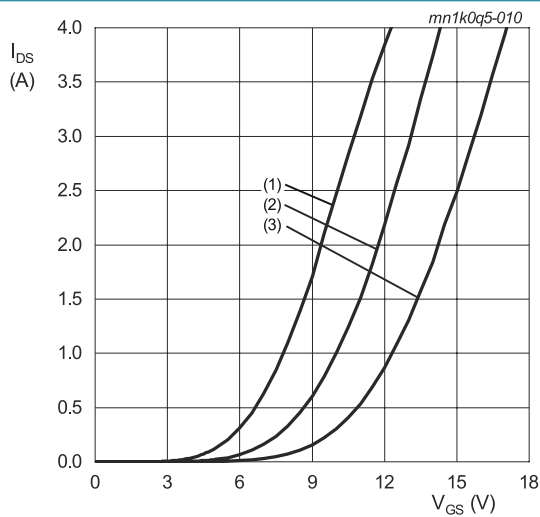
$I_{DS} = 1\text{ A}; V_{GS} = 18\text{ V}; t_p < 200\text{ }\mu\text{s}$   
**Fig. 7. Normalized drain-source on-state resistance as a function of junction temperature**



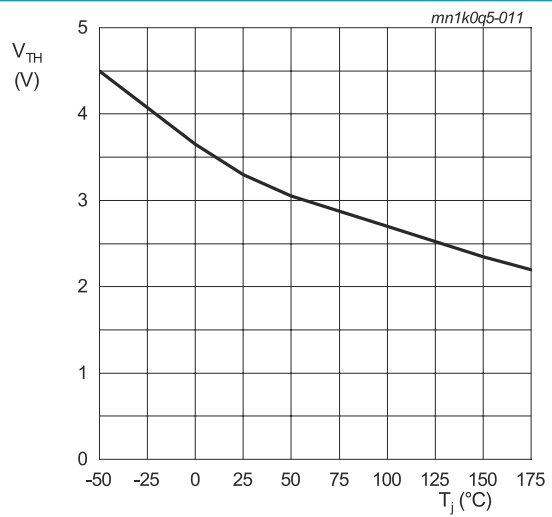
$V_{GS} = 18\text{ V}; t_p < 200\ \mu\text{s}$   
**Fig. 8. Drain-source on-state resistance as a function of drain current; typical values**



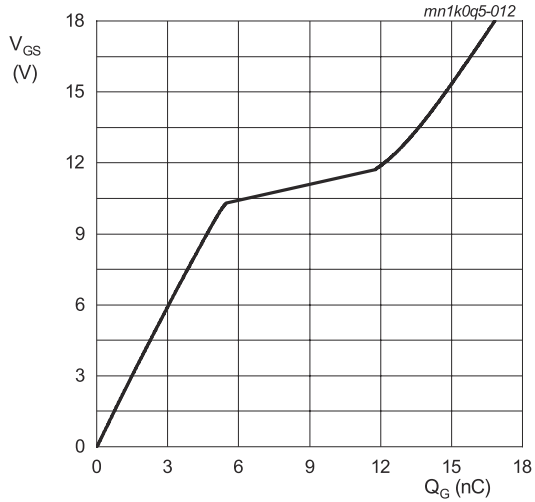
$I_{DS} = 1\text{ A}; t_p < 200\ \mu\text{s}$   
**Fig. 9. Drain-source on-state resistance as a function of junction temperature**



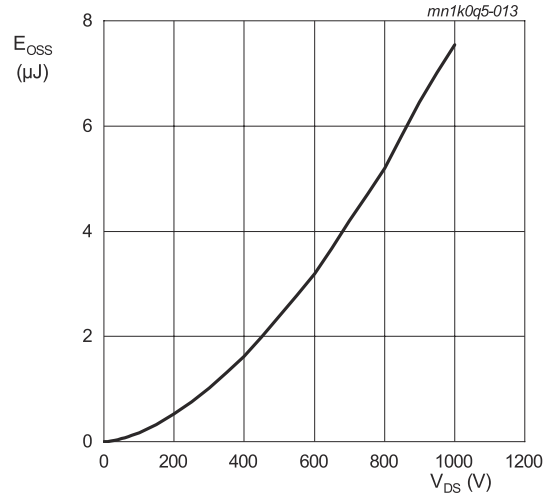
$V_{DS} = 10\text{ V}; t_p < 200\ \mu\text{s}$   
 (1)  $T_j = 150^\circ\text{C}$   
 (2)  $T_j = 25^\circ\text{C}$   
 (3)  $T_j = -55^\circ\text{C}$   
**Fig. 10. Transfer characteristics; drain current as a function of gate-source voltage; typical values**



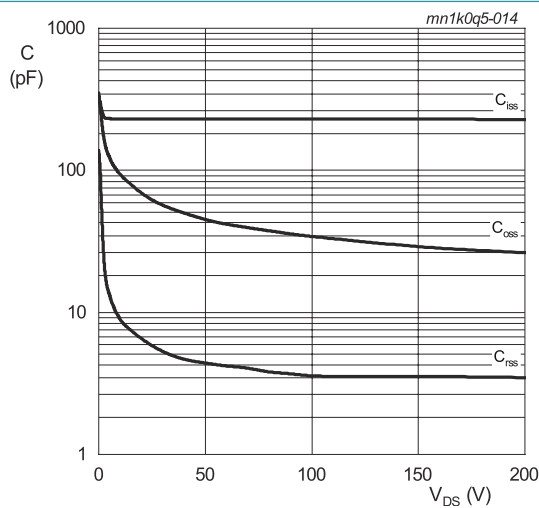
$V_{DS} = 10\text{ V}; I_{DS} = 0.8\text{ mA}$   
**Fig. 11. Threshold voltage as a function of junction temperature**



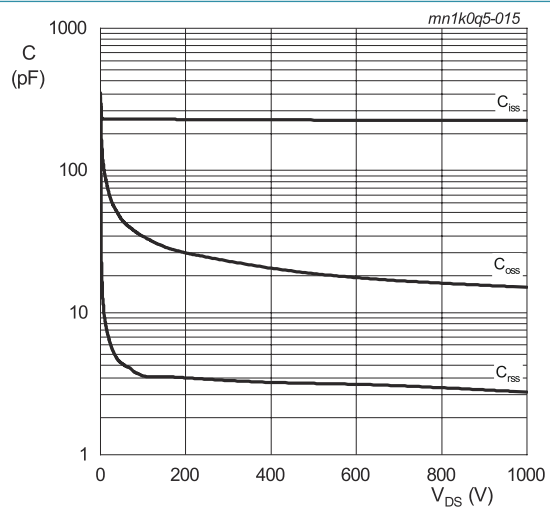
$I_{DS} = 2\text{ A}; I_{GS} = 0.1\text{ mA}; V_{DS} = 1200\text{ V}; T_j = 25\text{ }^\circ\text{C}$   
**Fig. 12. Gate-source voltage as a function of gate charge; typical values**



**Fig. 13. Output capacitor stored energy as a function of drain-source voltage**

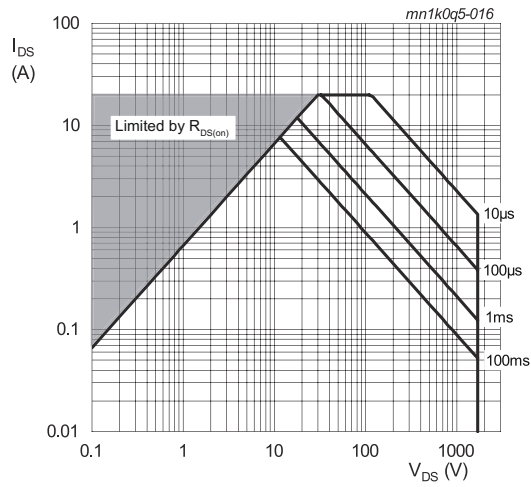


$V_{DS} = 0 - 200\text{ V}$   
 $T_j = 25\text{ }^\circ\text{C}; V_{AC} = 25\text{ mV}; f = 1\text{ MHz}$   
**Fig. 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values**



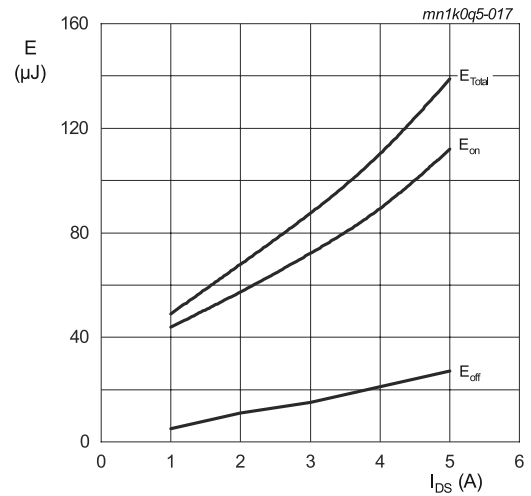
$V_{DS} = 0 - 1000\text{ V}$   
 $T_j = 25\text{ }^\circ\text{C}; V_{AC} = 25\text{ mV}; f = 1\text{ MHz}$   
**Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values**





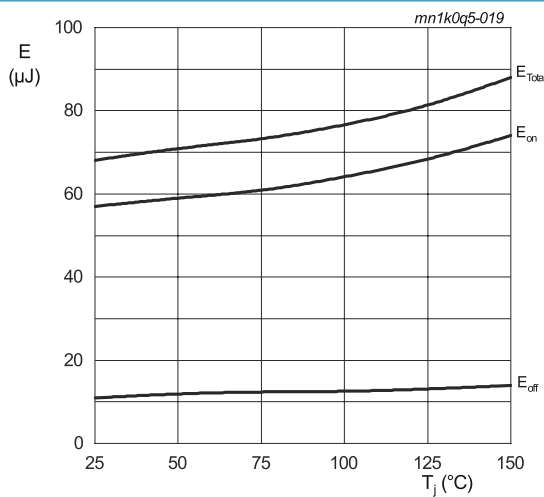
$T_c = 25\text{ }^\circ\text{C}$ ;  $D = 0$   
Parameter:  $t_p$

Fig. 16. Forward bias safe operating area



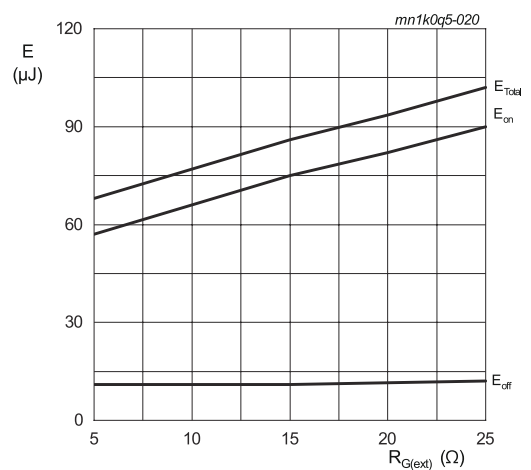
$T_j = 25\text{ }^\circ\text{C}$ ;  $V_{DD} = 1000\text{ V}$ ;  $R_{G(ext)} = 5.1\text{ }\Omega$ ;  
 $V_{GS} = -3\text{V}/18\text{ V}$ ;  $L = 4.8\text{ mH}$ ;  
FWD = WN5C2M1K0170W

Fig. 17. Clamped Inductive Switching Energy as a function of drain current



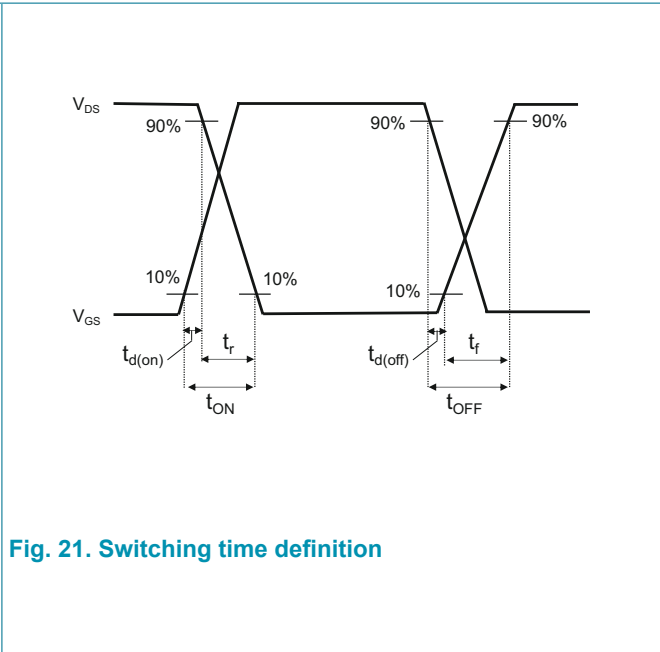
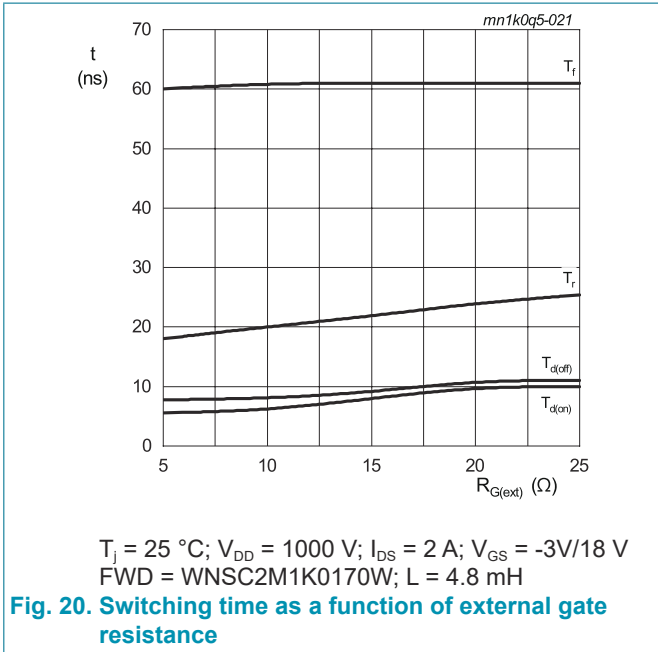
$I_{DS} = 2\text{ A}$ ;  $V_{DD} = 1000\text{ V}$ ;  $R_{G(ext)} = 5.1\text{ }\Omega$ ;  
 $V_{GS} = -3\text{V}/18\text{ V}$ ;  $L = 4.8\text{ mH}$ ;  
FWD = WN5C2M1K0170W

Fig. 18. Clamped Inductive Switching Energy as a function of junction temperature



$T_j = 25\text{ }^\circ\text{C}$ ;  $V_{DD} = 1000\text{ V}$ ;  $I_{DS} = 2\text{ A}$ ;  $V_{GS} = -3\text{V}/18\text{ V}$ ;  
FWD = WN5C2M1K0170W;  $L = 4.8\text{ mH}$

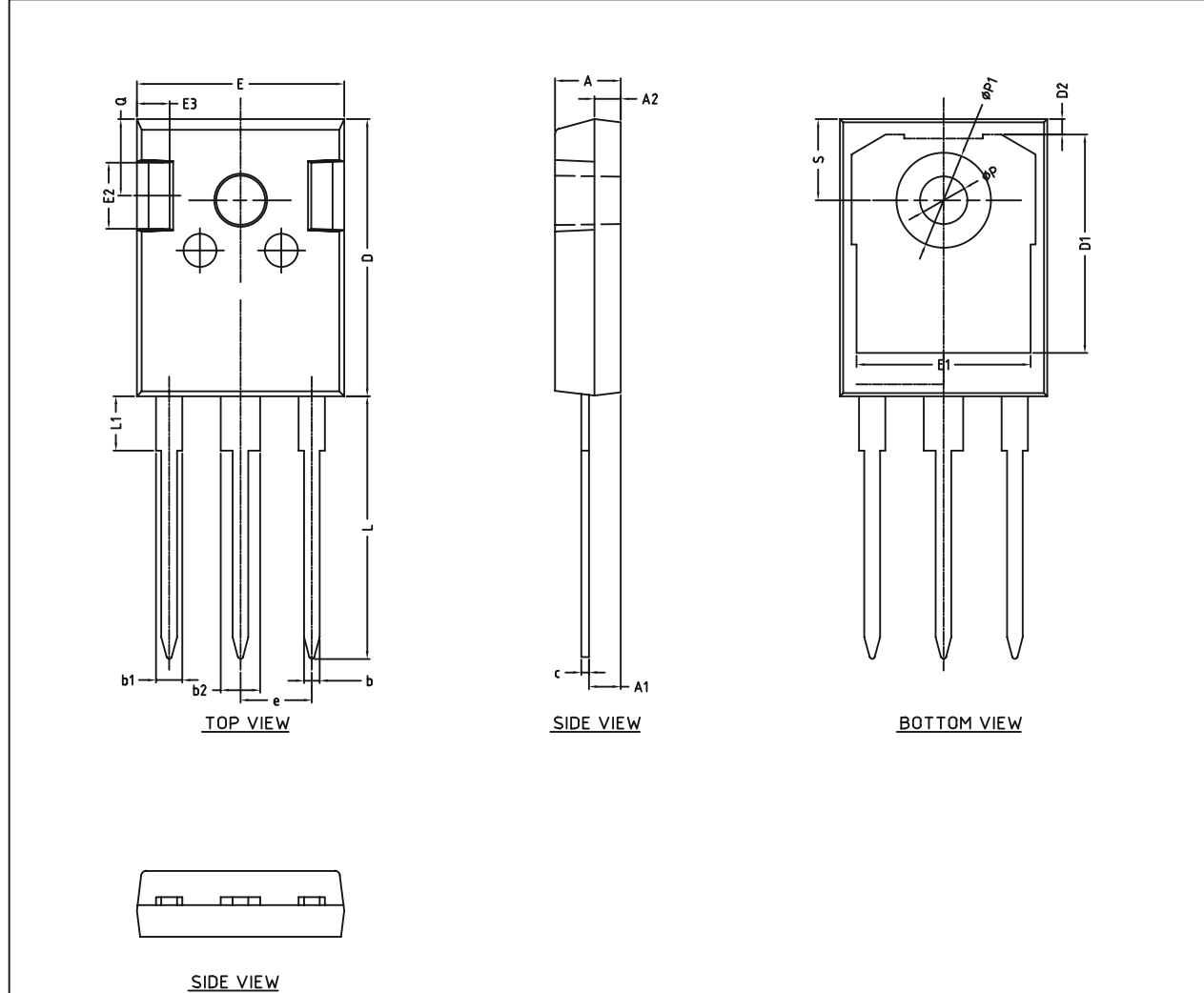
Fig. 19. Clamped Inductive Switching Energy as a function of external gate resistance



### 11. Package outline

Plastic single-ended through-hole package; heatsink mounted; 1 mounting hole; 3-lead TO-247

SOT429N



UNIT	A	A1	A2	b	b1	b2	c	D	D1	D2	E	E1	E2	E3	e	L	L1	P	P1	Q	S	
mm	MAX	5.20	2.60	2.10	1.40	2.20	3.20	0.70	21.10	16.85	1.35	15.90	13.50	5.20	2.60	5.45	20.10	4.75	3.70	7.40	6.00	6.25
	MIN	4.70	2.20	1.90	1.00	1.80	2.80	0.50	20.90	16.25	1.05	15.70	13.10	4.80	2.40		19.80	-	3.50	-	5.60	6.05

OUTLINE VERSION	REFERENCES				PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT429N		TO-247				

## 12. Legal information

### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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For more information, please visit: <http://www.ween-semi.com>  
For sales office addresses, please send an email to: [salesaddresses@ween-semi.com](mailto:salesaddresses@ween-semi.com)  
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